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FORM PTO-1449 (Rev. 2-32) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. DP-306551 (DEL01 P-392) SERIAL NO.

INFORMATION DISCLOSURE

STATEMENT BY APPLICANT

(Use several sheets if necessary)

APPLICANTS
S yed R. Zarabadi et al.

FILING DATE

**GROUP** 



### **U.S. PATENT DOCUMENTS**

EXAMINER		D	ocı	JM	ENT	NL	JMB	ER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
A	J	5	8	4	7	2	8	0	12/08/98	Sherman et al.	73	514	
Sw	V,	5	6	6	5	9	1	5	09/09/97	Kobayashi et al.	73	514	
CAP.	J	5	5	7	8	7	5	5	11/26/96	Offenberg	73	514	
SAY	>	5	5	6	9	8	5	2	10/29/96	Marek et al.	73	514	
Sys	>	5	5	4	0	0	9	5	07/30/96	Sherman et al.	73	514	
QUD PAR	$\searrow$	5	4	1	7	1	1	1	05/23/95	Sherman et al.	73	517	
(Mrs	V	5	3	8	8	4	6	0	02/14/95	Sakurai et al.	73	517	
	<b>\</b>	5	3	4	9	8	5	8	09/27/94	Yagi et al.	73	517	
\$	>	5	3	4	5	8	2	4	09/13/94	Sherman et al.	73	517	
	<b>\</b>	5	3	1	4	5	7	2	05/24/94	Core et al.	156	643	
M	<b>/</b>	5	3	1	0	4	5	0	05/10/94	Offenberg et al.	156	630	

## **FOREIGN PATENT DOCUMENTS**

		DO	DOCUMENT NUMBER						DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION		
													YES	NO	
M	1	0	5	8	3	3	9	7	12/1977	Russia	73	517A	X Abstract		
4/2	$\mathcal{J}$	1	0	3	5	5	2	3	08/1983	Russia	73	517A	X Abstract		
que la companya de la companya della companya della companya de la companya della	J	1	0	4	0	4	2	4	09/1983	Russia ,	73	517A	X Abstract		

## OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, Etc.)

$\int d$	"Rejecting Rotational Disturbances on Small Disk Drives Using Rotational Accelerometers" Daniel Y. Abramovitch, 1996, IFAC World Congress in San Francisco, CA 1996, pp. 1-6.
	"Increased Disturbance Rejection in Magnetic Disk Drives by Acceleration Feedforward Control and Parameter Adaption" M.T. White and M. Tomizuka, Vol. 5, No. 6, 1997, pp. 741-751.
	"Surface-Micromachined-Angular-Accelerometer-with-Force Peedback" T.d. Brosnihan, A.P. Pisano and R.T. Howe, DSG=Voi: 57-2, 1995, IMECE-pp: 941-947.
	/ "Embedded-Interconnect and Electrical-Isolation for High-Aspect-Ratio, SOI Inertial Instruments" T.J. Brosninan, J.M. Bustillo, A.P. Pisano and R.T. Howe, 1997. International Conference on Solid-State Sensors and Actuators, Chicago, June, 16-19-1997, pp637-640.

EXAMINE

DATE CONSIDERED

6/20/03

EXAMINER Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

(Form PTO-1449 [6-4])

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE	ATTY. DOCKET NO.	SERIAL NO.				
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## **U.S. PATENT DOCUMENTS**

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(1) xp	$\checkmark$	5	2	5	3	5	2	6	10/19/93	Omura et al.	73	517	
91	<b>√</b>	5	2	5	1	4	8	4	10/12/93	Mastache	73	517	
&	✓.	5	2	4	9	4	6	5	10/05/93	Bennett et al.	73	510	
Q.h	$\sqrt{}$	5	2	3	3	2	1	3	08/03/93	Marek	257	415	
<b>E</b>	>	5	2	2	6	3	2	1	07/13/93	Vamham et al.	73	505	
Q(V)	>	5	1	4	6	3	8	9	09/08/92	Ristic et al.	361	283	
91	V	5	0	9	2	1	7	4	03/03/92	Reidemeister et al.	73	517	
$\sim$	7	4	8	5	1	0	8	0	07/25/89	Howe et al.	156	647	
ANA	J	4	8	0	5	4	5	6	02/21/89	Howe et al.	73	517	
XXA	<b>V</b>	4	7	3	6	6	2	9	04/12/88	Cole	73	517	
ON	V′	4	6	9	9	0	0	6	10/13/87	Boxenhorn	73	517	
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# OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, Etc.)

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